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Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	1176
Number of Logic Elements/Cells	5292
Total RAM Bits	57344
Number of I/O	284
Number of Gates	200000
Voltage - Supply	2.375V ~ 2.625V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	456-BBGA
Supplier Device Package	456-FBGA (23x23)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc2s200-6fgg456c

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Spartan-II Product Availability

Table 2 shows the maximum user I/Os available on the device and the number of user I/Os available for each device/package combination. The four global clock pins are usable as additional user I/Os when not used as a global clock pin. These pins are not included in user I/O counts.

Table 2: Spartan-II FPGA User I/O Chart(1)

		Available User I/O According to Package Type							
Device	Maximum User I/O	VQ100 VQG100	TQ144 TQG144	CS144 CSG144	PQ208 PQG208	FG256 FGG256	FG456 FGG456		
XC2S15	86	60	86	(Note 2)	-	-	-		
XC2S30	92	60	92	92	(Note 2)	-	-		
XC2S50	176	-	92	-	140	176	-		
XC2S100	176	-	92	-	140	176	(Note 2)		
XC2S150	260	-	-	-	140	176	260		
XC2S200	284	-	-	-	140	176	284		

Notes:

1. All user I/O counts do not include the four global clock/user input pins.

2. Discontinued by PDN2004-01.

DS001-2 (v2.8) June 13, 2008

Architectural Description

Spartan-II FPGA Array

The Spartan[®]-II field-programmable gate array, shown in Figure 2, is composed of five major configurable elements:

- IOBs provide the interface between the package pins and the internal logic
- CLBs provide the functional elements for constructing most logic
- Dedicated block RAM memories of 4096 bits each
- Clock DLLs for clock-distribution delay compensation and clock domain control
- Versatile multi-level interconnect structure

As can be seen in Figure 2, the CLBs form the central logic structure with easy access to all support and routing structures. The IOBs are located around all the logic and

Spartan-II FPGA Family: Functional Description

Product Specification

memory elements for easy and quick routing of signals on and off the chip.

Values stored in static memory cells control all the configurable logic elements and interconnect resources. These values load into the memory cells on power-up, and can reload if necessary to change the function of the device.

Each of these elements will be discussed in detail in the following sections.

Input/Output Block

The Spartan-II FPGA IOB, as seen in Figure 2, features inputs and outputs that support a wide variety of I/O signaling standards. These high-speed inputs and outputs are capable of supporting various state of the art memory and bus interfaces. Table 3 lists several of the standards which are supported along with the required reference, output and termination voltages needed to meet the standard.



Figure 2: Spartan-II FPGA Input/Output Block (IOB)

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Similarly, the F6 multiplexer combines the outputs of all four function generators in the CLB by selecting one of the F5-multiplexer outputs. This permits the implementation of any 6-input function, an 8:1 multiplexer, or selected functions of up to 19 inputs.

Each CLB has four direct feedthrough paths, one per LC. These paths provide extra data input lines or additional local routing that does not consume logic resources.

Arithmetic Logic

Dedicated carry logic provides capability for high-speed arithmetic functions. The Spartan-II FPGA CLB supports two separate carry chains, one per slice. The height of the carry chains is two bits per CLB.

The arithmetic logic includes an XOR gate that allows a 1-bit full adder to be implemented within an LC. In addition, a dedicated AND gate improves the efficiency of multiplier implementation.

The dedicated carry path can also be used to cascade function generators for implementing wide logic functions.

BUFTs

Each Spartan-II FPGA CLB contains two 3-state drivers (BUFTs) that can drive on-chip busses. See "Dedicated Routing," page 12. Each Spartan-II FPGA BUFT has an independent 3-state control pin and an independent input pin.

Block RAM

Spartan-II FPGAs incorporate several large block RAM memories. These complement the distributed RAM Look-Up Tables (LUTs) that provide shallow memory structures implemented in CLBs.

Block RAM memory blocks are organized in columns. All Spartan-II devices contain two such columns, one along each vertical edge. These columns extend the full height of the chip. Each memory block is four CLBs high, and consequently, a Spartan-II device eight CLBs high will contain two memory blocks per column, and a total of four blocks.

Table 5: Spartan-II Block RAM Amounts

Spartan-II Device	# of Blocks	Total Block RAM Bits
XC2S15	4	16K
XC2S30	6	24K
XC2S50	8	32K
XC2S100	10	40K
XC2S150	12	48K
XC2S200	14	56K

Each block RAM cell, as illustrated in Figure 5, is a fully synchronous dual-ported 4096-bit RAM with independent control signals for each port. The data widths of the two ports can be configured independently, providing built-in bus-width conversion.



Figure 5: Dual-Port Block RAM

Table 6 shows the depth and width aspect ratios for the block RAM.

Table	6 [.]	Block	RAM	Port	Aspect	Ratios
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Width	Depth	ADDR Bus	Data Bus
1	4096	ADDR<11:0>	DATA<0>
2	2048	ADDR<10:0>	DATA<1:0>
4	1024	ADDR<9:0>	DATA<3:0>
8	512	ADDR<8:0>	DATA<7:0>
16	256	ADDR<7:0>	DATA<15:0>

The Spartan-II FPGA block RAM also includes dedicated routing to provide an efficient interface with both CLBs and other block RAMs.

Programmable Routing Matrix

It is the longest delay path that limits the speed of any worst-case design. Consequently, the Spartan-II routing architecture and its place-and-route software were defined in a single optimization process. This joint optimization minimizes long-path delays, and consequently, yields the best system performance.

The joint optimization also reduces design compilation times because the architecture is software-friendly. Design cycles are correspondingly reduced due to shorter design iteration times.

Bit 0 (TDO end) Bit 1 Bit 2	TDO.T TDO.O { Top-edge IOBs (Right to Left)
	Left-edge IOBs (Top to Bottom)
	MODE.I
	Bottom-edge IOBs (Left to Right)
▼ (TDI end)	Right-edge IOBs (Bottom to Top)

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Development System

Spartan-II FPGAs are supported by the Xilinx ISE[®] development tools. The basic methodology for Spartan-II FPGA design consists of three interrelated steps: design entry, implementation, and verification. Industry-standard tools are used for design entry and simulation, while Xilinx provides proprietary architecture-specific tools for implementation.

The Xilinx development system is integrated under a single graphical interface, providing designers with a common user interface regardless of their choice of entry and verification tools. The software simplifies the selection of implementation options with pull-down menus and on-line help.

For HDL design entry, the Xilinx FPGA development system provides interfaces to several synthesis design environments.

A standard interface-file specification, Electronic Design Interchange Format (EDIF), simplifies file transfers into and out of the development system.

Spartan-II FPGAs supported by a unified library of standard functions. This library contains over 400 primitives and macros, ranging from 2-input AND gates to 16-bit accumulators, and includes arithmetic functions, comparators, counters, data registers, decoders, encoders, I/O functions, latches, Boolean functions, multiplexers, shift registers, and barrel shifters.

The design environment supports hierarchical design entry. These hierarchical design elements are automatically combined by the implementation tools. Different design entry tools can be combined within a hierarchical design, thus allowing the most convenient entry method to be used for each portion of the design.

Design Implementation

The place-and-route tools (PAR) automatically provide the implementation flow described in this section. The partitioner takes the EDIF netlist for the design and maps the logic into the architectural resources of the FPGA (CLBs and IOBs, for example). The placer then determines the best locations for these blocks based on their interconnections and the desired performance. Finally, the router interconnects the blocks.

The PAR algorithms support fully automatic implementation of most designs. For demanding applications, however, the user can exercise various degrees of control over the process. User partitioning, placement, and routing information is optionally specified during the design-entry process. The implementation of highly structured designs can benefit greatly from basic floorplanning.

The implementation software incorporates timing-driven placement and routing. Designers specify timing requirements along entire paths during design entry. The timing path analysis routines in PAR then recognize these user-specified requirements and accommodate them.

Timing requirements are entered in a form directly relating to the system requirements, such as the targeted clock frequency, or the maximum allowable delay between two registers. In this way, the overall performance of the system along entire signal paths is automatically tailored to user-generated specifications. Specific timing information for individual nets is unnecessary.

Design Verification

In addition to conventional software simulation, FPGA users can use in-circuit debugging techniques. Because Xilinx devices are infinitely reprogrammable, designs can be verified in real time without the need for extensive sets of software simulation vectors.

The development system supports both software simulation and in-circuit debugging techniques. For simulation, the system extracts the post-layout timing information from the design database, and back-annotates this information into the netlist for use by the simulator. Alternatively, the user can verify timing-critical portions of the design using the static timing analyzer.

For in-circuit debugging, the development system includes a download cable, which connects the FPGA in the target system to a PC or workstation. After downloading the design into the FPGA, the designer can read back the contents of the flip-flops, and so observe the internal logic state. Simple modifications can be downloaded into the system in a matter of minutes.

Signals

There are two kinds of pins that are used to configure Spartan-II devices: Dedicated pins perform only specific configuration-related functions; the other pins can serve as general purpose I/Os once user operation has begun.

The dedicated pins comprise the mode pins (M2, M1, M0), the configuration clock pin (CCLK), the PROGRAM pin, the DONE pin and the boundary-scan pins (TDI, TDO, TMS, TCK). Depending on the selected configuration mode, CCLK may be an output generated by the FPGA, or may be generated externally, and provided to the FPGA as an input.

Note that some configuration pins can act as outputs. For correct operation, these pins require a V_{CCO} of 3.3V to drive an LVTTL signal or 2.5V to drive an LVCMOS signal. All the relevant pins fall in banks 2 or 3. The $\overline{\text{CS}}$ and $\overline{\text{WRITE}}$ pins for Slave Parallel mode are located in bank 1.

For a more detailed description than that given below, see "Pinout Tables" in Module 4 and XAPP176, Spartan-II FPGA Series Configuration and Readback.

The Process

The sequence of steps necessary to configure Spartan-II devices are shown in Figure 11. The overall flow can be divided into three different phases.

- Initiating Configuration
- Configuration memory clear
- Loading data frames
- Start-up

The memory clearing and start-up phases are the same for all configuration modes; however, the steps for the loading of data frames are different. Thus, the details for data frame loading are described separately in the sections devoted to each mode.

Initiating Configuration

There are two different ways to initiate the configuration process: applying power to the device or asserting the PROGRAM input.

Configuration on power-up occurs automatically unless it is delayed by the user, as described in a separate section below. The waveform for configuration on power-up is shown in Figure 12, page 19. Before configuration can begin, V_{CCO} Bank 2 must be greater than 1.0V. Furthermore, all V_{CCINT} power pins must be connected to a 2.5V supply. For more information on delaying configuration, see "Clearing Configuration Memory," page 19.

Once in user operation, the device can be re-configured simply by pulling the PROGRAM pin Low. The device acknowledges the beginning of the configuration process

by driving DONE Low, then enters the memory-clearing phase.



Figure 11: Configuration Flow Diagram



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Symbol		Description		Units
T _{DCC}		DIN setup	5	ns, min
T _{CCD}		DIN hold	0	ns, min
т _{ссо}		DOUT	12	ns, max
т _{ссн}	COLK	High time	5	ns, min
T _{CCL}		Low time	5	ns, min
F _{CC}		Maximum frequency	66	MHz, max

Figure 16: Slave Serial Mode Timing



Figure 33: Timing Diagram for Single-Port Block RAM Memory



Figure 34: Timing Diagram for a True Dual-Port Read/Write Block RAM Memory

property. This property could have one of the following seven values.

DRIVE=2 DRIVE=4 DRIVE=6 DRIVE=8 DRIVE=12 (Default) DRIVE=16 DRIVE=24

Design Considerations

Reference Voltage (V_{RFF}) Pins

Low-voltage I/O standards with a differential amplifier input buffer require an input reference voltage (V_{RFF}). Provide the V_{RFF} as an external signal to the device.

The voltage reference signal is "banked" within the device on a half-edge basis such that for all packages there are eight independent V_{RFF} banks internally. See Figure 36, page 39 for a representation of the I/O banks. Within each bank approximately one of every six I/O pins is automatically configured as a V_{RFF} input.

Within each V_{REF} bank, any input buffers that require a V_{RFF} signal must be of the same type. Output buffers of any type and input buffers can be placed without requiring a reference voltage within the same V_{REF} bank.

Output Drive Source Voltage (V_{CCO}) Pins

Many of the low voltage I/O standards supported by Versatile I/Os require a different output drive source voltage (V_{CCO}) . As a result each device can often have to support multiple output drive source voltages.

The V_{CCO} supplies are internally tied together for some packages. The VQ100 and the PQ208 provide one combined $V_{\mbox{\scriptsize CCO}}$ supply. The TQ144 and the CS144 packages provide four independent V_{CCO} supplies. The FG256 and the FG456 provide eight independent V_{CCO} supplies.

Output buffers within a given V_{CCO} bank must share the same output drive source voltage. Input buffers for LVTTL, LVCMOS2, PCI33_3, and PCI 66_3 use the V_{CCO} voltage for Input V_{CCO} voltage.

Transmission Line Effects

The delay of an electrical signal along a wire is dominated by the rise and fall times when the signal travels a short distance. Transmission line delays vary with inductance and capacitance, but a well-designed board can experience delays of approximately 180 ps per inch.

Transmission line effects, or reflections, typically start at 1.5" for fast (1.5 ns) rise and fall times. Poor (or non-existent) termination or changes in the transmission line impedance cause these reflections and can cause additional delay in longer traces. As system speeds continue to increase, the effect of I/O delays can become a limiting factor and therefore transmission line termination becomes increasingly more important.

Termination Techniques

A variety of termination techniques reduce the impact of transmission line effects.

The following lists output termination techniques:

None Series Parallel (Shunt) Series and Parallel (Series-Shunt)

Input termination techniques include the following:

None Parallel (Shunt)

These termination techniques can be applied in any combination. A generic example of each combination of termination methods appears in Figure 41.





Unterminated Output Driving a Parallel Terminated Input





Series Terminated Output Driving

Series-Parallel Terminated Output

Series Terminated Output



Driving a Parallel Terminated Input VTT





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Figure 41: Overview of Standard Input and Output **Termination Methods**

Simultaneous Switching Guidelines

Ground bounce can occur with high-speed digital ICs when multiple outputs change states simultaneously, causing undesired transient behavior on an output, or in the internal logic. This problem is also referred to as the Simultaneous Switching Output (SSO) problem.

Ground bounce is primarily due to current changes in the combined inductance of ground pins, bond wires, and

ground metallization. The IC internal ground level deviates from the external system ground level for a short duration (a few nanoseconds) after multiple outputs change state simultaneously.

Ground bounce affects stable Low outputs and all inputs because they interpret the incoming signal by comparing it to the internal ground. If the ground bounce amplitude exceeds the actual instantaneous noise margin, then a non-changing input can be interpreted as a short pulse with a polarity opposite to the ground bounce.

Table 18 provides the guidelines for the maximum numberof simultaneously switching outputs allowed per outputpower/ground pair to avoid the effects of ground bounce.Refer to Table 19 for the number of effective outputpower/ground pairs for each Spartan-II device and packagecombination.

Table 18: Maximum Number of Simultaneously Switching Outputs per Power/Ground Pair

	Package	
Standard	CS, FG	PQ, TQ, VQ
LVTTL Slow Slew Rate, 2 mA drive	68	36
LVTTL Slow Slew Rate, 4 mA drive	41	20
LVTTL Slow Slew Rate, 6 mA drive	29	15
LVTTL Slow Slew Rate, 8 mA drive	22	12
LVTTL Slow Slew Rate, 12 mA drive	17	9
LVTTL Slow Slew Rate, 16 mA drive	14	7
LVTTL Slow Slew Rate, 24 mA drive	9	5
LVTTL Fast Slew Rate, 2 mA drive	40	21
LVTTL Fast Slew Rate, 4 mA drive	24	12
LVTTL Fast Slew Rate, 6 mA drive	17	9
LVTTL Fast Slew Rate, 8 mA drive	13	7
LVTTL Fast Slew Rate, 12 mA drive	10	5
LVTTL Fast Slew Rate, 16 mA drive	8	4
LVTTL Fast Slew Rate, 24 mA drive	5	3
LVCMOS2	10	5
PCI	8	4
GTL	4	4
GTL+	4	4
HSTL Class I	18	9
HSTL Class III	9	5
HSTL Class IV	5	3
SSTL2 Class I	15	8

Table 18: Maximum Number of SimultaneouslySwitching Outputs per Power/Ground Pair

	Package		
Standard	CS, FG	PQ, TQ, VQ	
SSTL2 Class II	10	5	
SSTL3 Class I	11	6	
SSTL3 Class II	7	4	
СТТ	14	7	
AGP	9	5	

Notes:

1. This analysis assumes a 35 pF load for each output.

Table 19: Effective Output Power/Ground Pairs for Spartan-II Devices

	Spartan-II Devices									
Pkg.	XC2S 15	XC2S XC2S XC2S XC2S XC2S XC2S XC2S 15 30 50 100 150 200								
VQ100	8	8	-	-	-	-				
CS144	12	12	-	-	-	-				
TQ144	12	12	12	12	-	-				
PQ208	-	16	16	16	16	16				
FG256	-	-	16	16	16	16				
FG456	-	-	-	48	48	48				

Termination Examples

Creating a design with the Versatile I/O features requires the instantiation of the desired library primitive within the design code. At the board level, designers need to know the termination techniques required for each I/O standard.

This section describes some common application examples illustrating the termination techniques recommended by each of the standards supported by the Versatile I/O features. For a full range of accepted values for the DC voltage specifications for each standard, refer to the table associated with each figure.

The resistors used in each termination technique example and the transmission lines depicted represent board level components and are not meant to represent components on the device.

Input/Output		V _{IL}	V	н	V _{OL}	V _{OH}	I _{OL}	I _{ОН}
Standard	V, Min	V, Max	V, Min	V, Max	V, Max	V, Min	mA	mA
CTT	-0.5	V _{REF} – 0.2	V _{REF} + 0.2	3.6	V _{REF} – 0.4	V _{REF} + 0.4	8	-8
AGP	-0.5	V _{REF} – 0.2	V _{REF} + 0.2	3.6	10% V _{CCO}	90% V _{CCO}	Note (2)	Note (2)

Notes:

1. V_{OL} and V_{OH} for lower drive currents are sample tested.

2. Tested according to the relevant specifications.

Switching Characteristics

All devices are 100% functionally tested. Internal timing parameters are derived from measuring internal test patterns. Listed below are representative values. For more specific, more precise, and worst-case guaranteed data, use the values reported by the static timing analyzer (TRCE in the Xilinx Development System) and back-annotated to the simulation netlist. All timing parameters assume worst-case operating conditions (supply voltage and junction temperature). Values apply to all Spartan-II devices unless otherwise noted.

Global Clock Input to Output Delay for LVTTL, with DLL (Pin-to-Pin)⁽¹⁾

			S	peed Grad	le	
			All	-6	-5	
Symbol	Description	Device	Min	Max	Max	Units
T _{ICKOFDLL}	Global clock input to output delay using output flip-flop for LVTTL, 12 mA, fast slew rate, <i>with</i> DLL.	All		2.9	3.3	ns

Notes:

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

- Output timing is measured at 1.4V with 35 pF external capacitive load for LVTTL. The 35 pF load does not apply to the Min values. For other I/O standards and different loads, see the tables "Constants for Calculating TIOOP" and "Delay Measurement Methodology," page 60.
- 3. DLL output jitter is already included in the timing calculation.
- 4. For data *output* with different standards, adjust delays with the values shown in "IOB Output Delay Adjustments for Different Standards," page 59. For a global clock input with standards other than LVTTL, adjust delays with values from the "I/O Standard Global Clock Input Adjustments," page 61.

Global Clock Input to Output Delay for LVTTL, *without* DLL (Pin-to-Pin)⁽¹⁾

			All	-6	-5	
Symbol	Description	Device	Min	Max	Max	Units
T _{ICKOF}	Global clock input to output delay	XC2S15		4.5	5.4	ns
	using output flip-flop for LVTTL,	XC2S30		4.5	5.4	ns
	12 mA, fast slew rate, <i>without</i> DLL.	XC2S50		4.5	5.4	ns
		XC2S100		4.6	5.5	ns
		XC2S150		4.6	5.5	ns
		XC2S200		4.7	5.6	ns

Notes:

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

- Output timing is measured at 1.4V with 35 pF external capacitive load for LVTTL. The 35 pF load does not apply to the Min values. For other I/O standards and different loads, see the tables "Constants for Calculating TIOOP" and "Delay Measurement Methodology," page 60.
- For data *output* with different standards, adjust delays with the values shown in "IOB Output Delay Adjustments for Different Standards," page 59. For a global clock input with standards other than LVTTL, adjust delays with values from the "I/O Standard Global Clock Input Adjustments," page 61.

Calculation of T_{IOOP} as a Function of Capacitance

 $T_{\rm IOOP}$ is the propagation delay from the O Input of the IOB to the pad. The values for $T_{\rm IOOP}$ are based on the standard capacitive load (C_{SL}) for each I/O standard as listed in the table "Constants for Calculating TIOOP", below.

For other capacitive loads, use the formulas below to calculate an adjusted propagation delay, T_{IOOP1} .

$$T_{IOOP1} = T_{IOOP} + Adj + (C_{LOAD} - C_{SL}) * F_{L}$$

Where:

Adj is selected from "IOB Output Delay Adjustments for Different Standards", page 59, according to the I/O standard used

 $C_{\text{LOAD}}\,$ is the capacitive load for the design

F_L is the capacitance scaling factor

Delay Measurement Methodology

Standard	V _L (1)	V _H (1)	Meas. Point	V _{REF} Typ ⁽²⁾
LVTTL	0	3	1.4	-
LVCMOS2	0	2.5	1.125	-
PCI33_5	Pe	r PCI Spec		-
PCI33_3	Pe	r PCI Spec		-
PCI66_3	Pe	r PCI Spec		-
GTL	V _{REF} – 0.2	V _{REF} + 0.2	V_{REF}	0.80
GTL+	V _{REF} – 0.2	V _{REF} + 0.2	V_{REF}	1.0
HSTL Class I	V _{REF} – 0.5	V _{REF} + 0.5	V_{REF}	0.75
HSTL Class III	V _{REF} – 0.5	V _{REF} + 0.5	V_{REF}	0.90
HSTL Class IV	V _{REF} – 0.5	V _{REF} + 0.5	V_{REF}	0.90
SSTL3 I and II	V _{REF} – 1.0	V _{REF} + 1.0	V_{REF}	1.5
SSTL2 I and II	$V_{REF} - 0.75$	V _{REF} + 0.75	V_{REF}	1.25
CTT	V _{REF} – 0.2	V _{REF} + 0.2	V_{REF}	1.5
AGP	V _{REF} – (0.2xV _{CCO})	V _{REF} + (0.2xV _{CCO})	V _{REF}	Per AGP Spec

Notes:

- 1. Input waveform switches between V_L and V_H.
- 2. Measurements are made at V_{REF} Typ, Maximum, and Minimum. Worst-case values are reported.
- I/O parameter measurements are made with the capacitance values shown in the table, "Constants for Calculating TIOOP". See Xilinx application note <u>XAPP179</u> for the appropriate terminations.
- 4. I/O standard measurements are reflected in the IBIS model information except where the IBIS format precludes it.

Constants for Calculating T_{IOOP}

Standard	C _{SL} ⁽¹⁾ (pF)	F _L (ns/pF)
LVTTL Fast Slew Rate, 2 mA drive	35	0.41
LVTTL Fast Slew Rate, 4 mA drive	35	0.20
LVTTL Fast Slew Rate, 6 mA drive	35	0.13
LVTTL Fast Slew Rate, 8 mA drive	35	0.079
LVTTL Fast Slew Rate, 12 mA drive	35	0.044
LVTTL Fast Slew Rate, 16 mA drive	35	0.043
LVTTL Fast Slew Rate, 24 mA drive	35	0.033
LVTTL Slow Slew Rate, 2 mA drive	35	0.41
LVTTL Slow Slew Rate, 4 mA drive	35	0.20
LVTTL Slow Slew Rate, 6 mA drive	35	0.100
LVTTL Slow Slew Rate, 8 mA drive	35	0.086
LVTTL Slow Slew Rate, 12 mA drive	35	0.058
LVTTL Slow Slew Rate, 16 mA drive	35	0.050
LVTTL Slow Slew Rate, 24 mA drive	35	0.048
LVCMOS2	35	0.041
PCI 33 MHz 5V	50	0.050
PCI 33 MHZ 3.3V	10	0.050
PCI 66 MHz 3.3V	10	0.033
GTL	0	0.014
GTL+	0	0.017
HSTL Class I	20	0.022
HSTL Class III	20	0.016
HSTL Class IV	20	0.014
SSTL2 Class I	30	0.028
SSTL2 Class II	30	0.016
SSTL3 Class I	30	0.029
SSTL3 Class II	30	0.016
СТТ	20	0.035
AGP	10	0.037

Notes:

- 1. I/O parameter measurements are made with the capacitance values shown above. See Xilinx application note <u>XAPP179</u> for the appropriate terminations.
- 2. I/O standard measurements are reflected in the IBIS model information except where the IBIS format precludes it.

Clock Distribution Guidelines⁽¹⁾

		Speed Grade						
		-6	-5					
Symbol	Description	Max	Max	Units				
GCLK Clock Skew								
T _{GSKEWIOB}	Global clock skew between IOB flip-flops	0.13	0.14	ns				

Notes:

1. These clock distribution delays are provided for guidance only. They reflect the delays encountered in a typical design under worst-case conditions. Precise values for a particular design are provided by the timing analyzer.

Clock Distribution Switching Characteristics

T_{GPIO} is specified for LVTTL levels. For other standards, adjust T_{GPIO} with the values shown in "I/O Standard Global Clock Input Adjustments".

		Speed		
		-6	-5	
Symbol	Description	Max	Max	Units
GCLK IOB and But	ifer			
T _{GPIO}	Global clock pad to output	0.7	0.8	ns
T _{GIO}	Global clock buffer I input to O output	0.7	0.8	ns

I/O Standard Global Clock Input Adjustments

Delays associated with a global clock input pad are specified for LVTTL levels. For other standards, adjust the delays by the values shown. A delay adjusted in this way constitutes a worst-case limit.

			Speed Grade							
Symbol	Description	Standard	-6	-5	Units					
Data Input Delay Adjustments										
T _{GPLVTTL}	Standard-specific global clock	LVTTL	0	0	ns					
T _{GPLVCMOS2}	input delay adjustments	LVCMOS2	-0.04	-0.05	ns					
T _{GPPCI33_3}		PCI, 33 MHz, 3.3V	-0.11	-0.13	ns					
T _{GPPCI33_5}		PCI, 33 MHz, 5.0V	0.26	0.30	ns					
T _{GPPCI66_3}		PCI, 66 MHz, 3.3V	-0.11	-0.13	ns					
T _{GPGTL}		GTL	0.80	0.84	ns					
T _{GPGTLP}		GTL+	0.71	0.73	ns					
T _{GPHSTL}		HSTL	0.63	0.64	ns					
T _{GPSSTL2}		SSTL2	0.52	0.51	ns					
T _{GPSSTL3}		SSTL3	0.56	0.55	ns					
T _{GPCTT}		CTT	0.62	0.62	ns					
T _{GPAGP}		AGP	0.54	0.53	ns					

Notes:

1. Input timing for GPLVTTL is measured at 1.4V. For other I/O standards, see the table "Delay Measurement Methodology," page 60.

CLB Distributed RAM Switching Characteristics

			Speed Grade				
		-6		-5			
Symbol	Description	Min	Max	Min	Max	Units	
Sequential Dela	ys		·				
Т _{SHCKO16}	Clock CLK to X/Y outputs (WE active, 16 x 1 mode)	-	2.2	-	2.6	ns	
Т _{SHCKO32}	Clock CLK to X/Y outputs (WE active, 32 x 1 mode)	-	2.5	-	3.0	ns	
Setup/Hold Time	es with Respect to Clock CLK ⁽¹⁾						
T _{AS} / T _{AH}	F/G address inputs	0.7 / 0	-	0.7 / 0	-	ns	
T _{DS} / T _{DH}	BX/BY data inputs (DIN)	0.8 / 0	-	0.9/0	-	ns	
T _{WS} / T _{WH}	CE input (WS)	0.9/0	-	1.0/0	-	ns	
Clock CLK							
T _{WPH}	Minimum pulse width, High	-	2.9	-	2.9	ns	
T _{WPL}	Minimum pulse width, Low	-	2.9	-	2.9	ns	
T _{WC}	Minimum clock period to meet address write cycle time	-	5.8	-	5.8	ns	

Notes:

1. A zero hold time listing indicates no hold time or a negative hold time.

CLB Shift Register Switching Characteristics

		Speed Grade				
		-6		-5		
Symbol	Description	Min	Max	Min	Max	Units
Sequential Dela	ys					
T _{REG}	Clock CLK to X/Y outputs	-	3.47	-	3.88	ns
Setup Times with	th Respect to Clock CLK					
T _{SHDICK}	BX/BY data inputs (DIN)	0.8	-	0.9	-	ns
T _{SHCECK}	CE input (WS)	0.9	-	1.0	-	ns
Clock CLK						
T _{SRPH}	Minimum pulse width, High	-	2.9	-	2.9	ns
T _{SRPL}	Minimum pulse width, Low	-	2.9	-	2.9	ns

Package	Leads	Туре	Maximum I/O	Lead Pitch (mm)	Footprint Area (mm)	Height (mm)	Mass ⁽¹⁾ (g)
VQ100 / VQG100	100	Very Thin Quad Flat Pack (VQFP)	60	0.5	16 x 16	1.20	0.6
TQ144 / TQG144	144	Thin Quad Flat Pack (TQFP)	92	0.5	22 x 22	1.60	1.4
CS144 / CSG144	144	Chip Scale Ball Grid Array (CSBGA)	92	0.8	12 x 12	1.20	0.3
PQ208 / PQG208	208	Plastic Quad Flat Pack (PQFP)	140	0.5	30.6 x 30.6	3.70	5.3
FG256 / FGG256	256	Fine-pitch Ball Grid Array (FBGA)	176	1.0	17 x 17	2.00	0.9
FG456 / FGG456	456	Fine-pitch Ball Grid Array (FBGA)	284	1.0	23 x 23	2.60	2.2

Table 36: Spartan-II Family Package Options

Notes:

1. Package mass is $\pm 10\%$.

Note: Some early versions of Spartan-II devices, including the XC2S15 and XC2S30 ES devices and the XC2S150 with date code 0045 or earlier, included a power-down pin. For more information, see <u>Answer Record 10500</u>.

VCCO Banks

Some of the I/O standards require specific V_{CCO} voltages. These voltages are externally connected to device pins that serve groups of IOBs, called banks. Eight I/O banks result from separating each edge of the FPGA into two banks (see Figure 3 in Module 2). Each bank has multiple V_{CCO} pins which must be connected to the same voltage. In the smaller packages, the V_{CCO} pins are connected between banks, effectively reducing the number of independent banks available (see Table 37). These interconnected banks are shown in the Pinout Tables with V_{CCO} pads for multiple banks connected to the same pin.

Table 37: Independent VCCO Banks Available

Package	VQ100	CS144	FG256
	PQ208	TQ144	FG456
Independent Banks	1	4	8

Package Overview

Table 36 shows the six low-cost, space-saving productionpackage styles for the Spartan-II family.

Each package style is available in an environmentally friendly lead-free (Pb-free) option. The Pb-free packages include an extra 'G' in the package style name. For example, the standard "CS144" package becomes "CSG144" when ordered as the Pb-free option. Leaded (non-Pb-free) packages may be available for selected devices, with the same pin-out and without the "G" in the ordering code; contact Xilinx sales for more information. The mechanical dimensions of the standard and Pb-free packages are similar, as shown in the mechanical drawings provided in Table 38. For additional package information, see <u>UG112</u>: *Device Package User Guide*.

Mechanical Drawings

Detailed mechanical drawings for each package type are available from the Xilinx web site at the specified location in Table 38.

Material Declaration Data Sheets (MDDS) are also available on the <u>Xilinx web site</u> for each package.

Table 38: Xilinx Package Documentation

Package	Drawing	MDDS
VQ100	Package Drawing	PK173_VQ100
VQG100		PK130_VQG100
TQ144	Package Drawing	PK169_TQ144
TQG144		PK126_TQG144
CS144	Package Drawing	PK149_CS144
CSG144		PK103_CSG144
PQ208	Package Drawing	PK166_PQ208
PQG208		PK123_PQG208
FG256	Package Drawing	PK151_FG256
FGG256		PK105_FGG256
FG456	Package Drawing	PK154_FG456
FGG456		PK109_FGG456

XC2S30 Device Pinouts (Continued)

XC2S30 Pad Name						Bndry
Function	Bank	VQ100	TQ144	CS144	PQ208	Scan
I/O	4	-	-	-	P87	295
I/O	4	-	-	-	P88	298
I/O	4	-	P84	K8	P89	301
I/O	4	-	P83	N9	P90	304
V _{CCINT}	-	P42	P82	M9	P91	-
V _{CCO}	4	-	-	-	P92	-
GND	-	-	P81	L9	P93	-
I/O	4	P43	P80	K9	P94	307
I/O	4	P44	P79	N10	P95	310
I/O	4	-	P78	M10	P96	313
I/O, V _{REF}	4	P45	P77	L10	P98	316
I/O	4	-	-	-	P99	319
I/O	4	-	P76	N11	P100	322
I/O	4	P46	P75	M11	P101	325
I/O	4	P47	P74	L11	P102	328
GND	-	P48	P73	N12	P103	-
DONE	3	P49	P72	M12	P104	331
V _{CCO}	4	P50	P71	N13	P105	-
V _{CCO}	3	P50	P70	M13	P105	-
PROGRAM	-	P51	P69	L12	P106	334
I/O (INIT)	3	P52	P68	L13	P107	335
I/O (D7)	3	P53	P67	K10	P108	338
I/O	3	-	P66	K11	P109	341
I/O	3	-	-	-	P110	344
I/O, V _{REF}	3	P54	P65	K12	P111	347
I/O	3	-	P64	K13	P113	350
I/O	3	P55	P63	J10	P114	353
I/O (D6)	3	P56	P62	J11	P115	356
GND	-	-	P61	J12	P116	-
V _{CCO}	3	-	-	-	P117	-
I/O (D5)	3	P57	P60	J13	P119	359
I/O	3	P58	P59	H10	P120	362
I/O	3	-	-	-	P121	365
I/O	3	-	-	-	P122	368
I/O	3	-	-	-	P123	371
GND	-	-	-	-	P124	-
I/O, V _{REF}	3	P59	P58	H11	P125	374
I/O (D4)	3	P60	P57	H12	P126	377
I/O	3	-	P56	H13	P127	380
V _{CCINT}	-	P61	P55	G12	P128	-
I/O, TRDY ⁽¹⁾	3	P62	P54	G13	P129	386
., e,	•			0.0	=•	

XC2S30 Device Pinouts (Continued)

XC2S30 Pad Name						Bndry
Function	Bank	VQ100	TQ144	CS144	PQ208	Scan
V _{CCO}	3	P63	P53	G11	P130	-
V _{CCO}	2	P63	P53	G11	P130	-
GND	-	P64	P52	G10	P131	-
I/O, IRDY ⁽¹⁾	2	P65	P51	F13	P132	389
I/O	2	-	-	-	P133	392
I/O	2	-	P50	F12	P134	395
I/O (D3)	2	P66	P49	F11	P135	398
I/O, V _{REF}	2	P67	P48	F10	P136	401
GND	-	-	-	-	P137	-
I/O	2	-	-	-	P138	404
I/O	2	-	-	-	P139	407
I/O	2	-	-	-	P140	410
I/O	2	P68	P47	E13	P141	413
I/O (D2)	2	P69	P46	E12	P142	416
V _{CCO}	2	-	-	-	P144	-
GND	-	-	P45	E11	P145	-
I/O (D1)	2	P70	P44	E10	P146	419
I/O	2	P71	P43	D13	P147	422
I/O	2	-	P42	D12	P148	425
I/O, V _{REF}	2	P72	P41	D11	P150	428
I/O	2	-	-	-	P151	431
I/O	2	-	P40	C13	P152	434
I/O (DIN, D0)	2	P73	P39	C12	P153	437
I/O (DOUT, BUSY)	2	P74	P38	C11	P154	440
CCLK	2	P75	P37	B13	P155	443
V _{CCO}	2	P76	P36	B12	P156	-
V _{CCO}	1	P76	P35	A13	P156	-
TDO	2	P77	P34	A12	P157	-
GND	-	P78	P33	B11	P158	-
TDI	-	P79	P32	A11	P159	-
I/O (CS)	1	P80	P31	D10	P160	0
I/O (WRITE)	1	P81	P30	C10	P161	3
I/O	1	-	P29	B10	P162	6
I/O	1	-	-	-	P163	9
I/O, V _{REF}	1	P82	P28	A10	P164	12
I/O	1	-	-	-	P166	15
I/O	1	P83	P27	D9	P167	18
I/O	1	P84	P26	C9	P168	21
GND	-	-	P25	B9	P169	-
V _{CCO}	1	-	-	-	P170	-

Additional XC2S50 Package Pins (Continued)

PQ208

Not Connected Pins							
P55	P56	-	-	-	-		
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FG256

C3 C14 D4 D13 E5 E12 M5 M12 N4 N13 P3 P14 Vcco Bark 0 Pins Vcco Bark 1 Pins P3 P14 E8 F8 - - - E9 F9 - - - H11 H12 - - - Vcco Bark 2 Pins - - - H11 H12 - - - Vcco Bark 2 Pins - - - J11 J12 - - - Vcco Bark 3 Pins - - - - J11 J12 - - - - U9 M9 - - - - L9 M9 - - - - J5 J6 - - - - H5 H6 - - - - <t< th=""><th colspan="9">V_{CCINT} Pins</th></t<>	V _{CCINT} Pins								
M5 M12 N4 N13 P3 P14 V _{CCO} Bank 0 Pins V P14 V P14 E8 F8 - - - - E9 F9 - - - - H11 H12 - - - - WCCO Bank 2 Pins VCCO Bank 3 Pins - - - J11 J12 - - - - VCCO Bank 3 Pins - - - - J11 J12 - - - - U9 M9 - - - - L9 M9 - - - - U9 M9 - - - - L9 M9 - - - - L9 M9 - - - - J5 J6 - - - - -	C3	C14	D4	D13	E5	E12			
V _{CCO} Bark 0 Pins E8 F8 - - - V _{CCO} Bark 1 Pins E9 F9 - - - V _{CCO} Bark 2 Pins H11 H12 - - - V _{CCO} Bark 2 Pins H11 H12 - - - V _{CCO} Bark 3 Pins J11 J12 - - - V _{CCO} Bark 4 Pins L9 M9 - - - - L9 M9 - - - - - L8 M8 - - - - - Structure of the structure	M5	M12	N4	N13	P3	P14			
E8 F8 - - - - - E9 F9 - - - - - E9 F9 - - - - - H11 H12 - - - - - H11 H12 - - - - - J11 J12 - - - - - L9 M9 - - - - - - L9 M9 - - - - - - J5 J6 - - - - - - H5 H6 - - - - - -			V _{CCO} Ba	nk 0 Pins					
V _{CCO} Bark 1 Pins E9 F9 - - - V _{CCO} Bark 2 Pins H11 H12 - - - V _{CCO} Bark 3 Pins J11 J12 - - - V _{CCO} Bark 3 Pins J11 J12 - - - V _{CCO} Bark 4 Pins L9 M9 - - - - V _{CCO} Bark 5 Pins L8 M8 - - - - V _{CCO} Bark 5 Pins J5 J6 - - - - J5 J6 - - - - - H5 H6 - - - - - H5 H6 - - - - - H5 H6 - - - - - M1 A16 B2 B15 F6 F7 F10 F11 G6 G7	E8	F8	-	-	-	-			
E9 F9 - - - - H11 H12 - - - - H11 H12 - - - - J11 J12 - - - - J11 J12 - - - - U11 J12 - - - - U2 M9 - - - - L9 M9 - - - - L9 M9 - - - - L9 M9 - - - - - L9 M9 - - - - - L9 M9 - - - - - L8 M8 - - - - - J5 J6 - - - - - H5 H6 - - - - - A1 A16 B2 B1			V _{CCO} Ba	nk 1 Pins					
V _{CCO} Bark 2 Pins H11 H12 - - - V _{CCO} Bark 3 Pins J11 J12 - - - V _{CCO} Bark 4 Pins U - - V _{CCO} Bark 4 Pins L9 M9 - - - V _{CCO} Bark 5 Pins L8 M8 - - V _{CCO} Bark 6 Pins J5 J6 - J5 J6 - J5 J6 - J5 J6 - J11 C V _{CCO} Bark 7 Pins H5 H6 - - GND Pins A1 A16 B2 B15 F6 F7 F10 F11 G6 G7 G8 G9 G10 <	E9	F9	-	-	-	-			
H11 H12 - - - - V _{CCO} Bark 3 Pins J11 J12 - - - VCCO Bark 4 Pins V V Pins - L9 M9 - - - - V2CO Bark 5 Pins - - - - L8 M8 - - - - J5 J6 - - - - J5 J6 - - - - J5 J6 - - - - H5 H6 - - - - - K11 G6 G7 G8 G9 G9 G10 K11 L6 L7 J7 J8 J9 J10 K6 K7 K8 K9 K10<			V _{CCO} Ba	nk 2 Pins					
V _{CCO} Bark 3 Pins J11 J12 - - - V _{CCO} Bark 4 Pins L9 M9 - - - - V _{CCO} Bark 4 Pins L9 M9 - - - - V _{CCO} Bark 5 Pins L8 M8 - - - - V _{CCO} Bark 6 Pins J5 J6 - - - - J5 J6 - - - - J5 J6 - <t< td=""><td>H11</td><td>H12</td><td>-</td><td>-</td><td>-</td><td>-</td></t<>	H11	H12	-	-	-	-			
J11 J12 - - - - V _{CCO} Bark 4 Pins L9 M9 - - - V _{CCO} Bark 5 Pins L8 M8 - - - L8 M8 - - - - J5 J6 - - - - J5 J6 - - - - H5 H6 - - - - K11 G6 G7 G8 G9 G10 G10 G11 H7 H8 H9 H10 J7 J7 J8 J9 J10 K6 K7 K8 K9 K10 <th< td=""><td></td><td></td><td>V_{CCO} Ba</td><td>nk 3 Pins</td><td></td><td></td></th<>			V _{CCO} Ba	nk 3 Pins					
V _{CCO} Bark 4 Pins L9 M9 - - - V _{CCO} Bark 5 Pins L8 M8 - - - - L8 M8 - - - - - J5 M6 - - - - - J5 J6 - - - - - M5 H6 - - - - - H5 H6 - - - - - H5 H6 - - - - - H5 H6 - - - - - M1 A16 B2 B15 F6 F7 F10 F11 G66 G7 G8 G9 G10 G11 H7 H8 H9 H10 J7 J8 J9 J10 K6 K7	J11	J12	-	-	-	-			
L9 M9 -			V _{CCO} Ba	nk 4 Pins					
V _{CCO} Bark 5 Pins L8 M8 - - - V_{CCO} Bark 6 Pins V V O - - J5 J6 - - - - - J5 J6 - - Pins - - H5 H6 - - - - - H5 H6 - </td <td>L9</td> <td>M9</td> <td>-</td> <td>-</td> <td>-</td> <td>-</td>	L9	M9	-	-	-	-			
L8 M8 -			V _{CCO} Ba	nk 5 Pins					
V _{CCO} Bark 6 Pins J5 J6 - - - V _{CCO} Bark 7 Pins H5 H6 - - - - H5 H6 - - - - - H5 H6 - - - - - - H5 H6 P - - - - - H5 H6 P - - - - - H5 H6 P - - - - - H5 H6 B2 B15 F6 F7 F10 F11 G6 G7 G8 G9 G10 G11 H7 H8 H9 H10 J7 J8 J9 J10 K6 K7 K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 <td>L8</td> <td>M8</td> <td>-</td> <td>-</td> <td>-</td> <td>-</td>	L8	M8	-	-	-	-			
J5 J6 - - - - V _{CCO} Bark 7 Pins H5 H6 - - - - H5 H6 - - - - - H5 H6 - - - - - - K1 A16 B2 B15 F6 F7 F1 F10 F11 G6 G7 G8 G9 G10 G11 H7 H8 H9 H10 J7 J8 J9 J10 K6 K7 K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -			V _{CCO} Ba	nk 6 Pins					
V _{CCO} Bark 7 Pins H5 H6 - - - GND Pins A1 A16 B2 B15 F6 F7 F10 F11 G6 G7 G8 G9 G10 G11 H7 H8 H9 H10 J7 J8 J9 J10 K6 K7 K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -	J5	J6	-	-	-	-			
H5 H6 - - - - GND Pins A1 A16 B2 B15 F6 F7 F10 F11 G6 G7 G8 G9 G10 G11 H7 H8 H9 H10 J7 J8 J9 J10 K6 K7 K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -			V _{CCO} Ba	nk 7 Pins					
GND Pins A1 A16 B2 B15 F6 F7 F10 F11 G6 G7 G8 G9 G10 G11 H7 H8 H9 H10 J7 J8 J9 J10 K6 K7 K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -	H5	H6	-	-	-	-			
A1 A16 B2 B15 F6 F7 F10 F11 G6 G7 G8 G9 G10 G11 H7 H8 H9 H10 J7 J8 J9 J10 K6 K7 K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -			GND	Pins					
F10 F11 G6 G7 G8 G9 G10 G11 H7 H8 H9 H10 J7 J8 J9 J10 K6 K7 K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -	A1	A16	B2	B15	F6	F7			
G10 G11 H7 H8 H9 H10 J7 J8 J9 J10 K6 K7 K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -	F10	F11	G6	G7	G8	G9			
J7 J8 J9 J10 K6 K7 K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -	G10	G11	H7	H8	H9	H10			
K8 K9 K10 K11 L6 L7 L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -	J7	J8	J9	J10	K6	K7			
L10 L11 R2 R15 T1 T16 Not Connected Pins P4 R4 - - - -	K8	K9	K10	K11	L6	L7			
Not Connected Pins P4 R4 - - - -	L10	L11	R2	R15	T1	T16			
P4 R4			Not Conne	ected Pins					
	P4	R4	-	-	-	-			

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XC2S100 Device Pinouts

XC2S100 Pad Name						Bndry
Function	Bank	TQ144	PQ208	FG256	FG456	Scan
GND	-	P143	P1	GND*	GND*	-
TMS	-	P142	P2	D3	D3	-
I/O	7	P141	P3	C2	B1	185
I/O	7	-	-	A2	F5	191
I/O	7	P140	P4	B1	D2	194
I/O	7	-	-	-	E3	197
I/O	7	-	-	E3	G5	200
I/O	7	-	P5	D2	F3	203
GND	-	-	-	GND*	GND*	-
V _{CCO}	7	-	-	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
I/O, V _{REF}	7	P139	P6	C1	E2	206

XC2S100 Device Pinouts (Continued)

XC2S100 Pad Name						Pndny
Function	Bank	TQ144	PQ208	FG256	FG456	Scan
I/O	7	-	P7	F3	E1	209
I/O	7	-	-	E2	H5	215
I/O	7	P138	P8	E4	F2	218
I/O	7	-	-	-	F1	221
I/O, V _{REF}	7	P137	P9	D1	H4	224
I/O	7	P136	P10	E1	G1	227
GND	-	P135	P11	GND*	GND*	-
V _{CCO}	7	-	P12	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
V _{CCINT}	-	-	P13	V _{CCINT} *	V_{CCINT}^{*}	-
I/O	7	P134	P14	F2	H3	230
I/O	7	P133	P15	G3	H2	233
I/O	7	-	-	F1	J5	236
I/O	7	-	P16	F4	J2	239
I/O	7	-	P17	F5	K5	245
I/O	7	-	P18	G2	K1	248
GND	-	-	P19	GND*	GND*	-
I/O, V _{REF}	7	P132	P20	H3	K3	251
I/O	7	P131	P21	G4	K4	254
I/O	7	-	-	H2	L6	257
I/O	7	P130	P22	G5	L1	260
I/O	7	-	P23	H4	L4	266
I/O, IRDY ⁽¹⁾	7	P129	P24	G1	L3	269
GND	-	P128	P25	GND*	GND*	-
V _{CCO}	7	P127	P26	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
V _{CCO}	6	P127	P26	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
I/O, TRDY ⁽¹⁾	6	P126	P27	J2	M1	272
V _{CCINT}	-	P125	P28	V_{CCINT}^{*}	V_{CCINT}^{*}	-
I/O	6	P124	P29	H1	M3	281
I/O	6	-	-	J4	M4	284
I/O	6	P123	P30	J1	M5	287
I/O, V _{REF}	6	P122	P31	J3	N2	290
GND	-	-	P32	GND*	GND*	-
I/O	6	-	P33	K5	N3	293
I/O	6	-	P34	K2	N4	296
I/O	6	-	P35	K1	P2	302
I/O	6	-	-	K3	P4	305
I/O	6	P121	P36	L1	P3	308
I/O	6	P120	P37	L2	R2	311

XC2S150 Device Pinouts

XC2S150 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
GND	-	P1	GND*	GND*	-
TMS	-	P2	D3	D3	-
I/O	7	P3	C2	B1	221
I/O	7	-	-	E4	224
I/O	7	-	-	C1	227
I/O	7	-	A2	F5	230
GND	-	-	GND*	GND*	-
I/O	7	P4	B1	D2	233
I/O	7	-	-	E3	236
I/O	7	-	-	F4	239
I/O	7	-	E3	G5	242
I/O	7	P5	D2	F3	245
GND	-	-	GND*	GND*	-
V _{CCO}	7	-	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
I/O, V _{REF}	7	P6	C1	E2	248
I/O	7	P7	F3	E1	251
I/O	7	-	-	G4	254
I/O	7	-	-	G3	257
I/O	7	-	E2	H5	260
I/O	7	P8	E4	F2	263
I/O	7	-	-	F1	266
I/O, V _{REF}	7	P9	D1	H4	269
I/O	7	P10	E1	G1	272
GND	-	P11	GND*	GND*	-
V _{CCO}	7	P12	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
V _{CCINT}	-	P13	V _{CCINT} *	V _{CCINT} *	-
I/O	7	P14	F2	H3	275
I/O	7	P15	G3	H2	278
I/O	7	-	-	H1	284
I/O	7	-	F1	J5	287
I/O	7	P16	F4	J2	290
I/O	7	-	-	J3	293
I/O	7	P17	F5	K5	299
I/O	7	P18	G2	K1	302
GND	-	P19	GND*	GND*	-
V _{CCO}	7	-	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
I/O, V _{REF}	7	P20	H3	K3	305
I/O	7	P21	G4	K4	308
I/O	7	-	H2	L6	311

XC2S150 Device Pinouts (Continued)

XC2S150 Pad Name					Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	7	P22	G5	L1	314
I/O	7	-	-	L5	317
I/O	7	P23	H4	L4	320
I/O, IRDY ⁽¹⁾	7	P24	G1	L3	323
GND	-	P25	GND*	GND*	-
V _{CCO}	7	P26	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
V _{CCO}	6	P26	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
I/O, TRDY ⁽¹⁾	6	P27	J2	M1	326
V _{CCINT}	-	P28	V_{CCINT}^{*}	V_{CCINT}^{*}	-
I/O	6	-	-	M6	332
I/O	6	P29	H1	M3	335
I/O	6	-	J4	M4	338
I/O	6	P30	J1	M5	341
I/O, V _{REF}	6	P31	J3	N2	344
V _{CCO}	6	-	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
GND	-	P32	GND*	GND*	-
I/O	6	P33	K5	N3	347
I/O	6	P34	K2	N4	350
I/O	6	-	-	N5	356
I/O	6	P35	K1	P2	359
I/O	6	-	K3	P4	362
I/O	6	-	-	R1	365
I/O	6	P36	L1	P3	371
I/O	6	P37	L2	R2	374
V _{CCINT}	-	P38	V _{CCINT} *	V _{CCINT} *	-
V _{CCO}	6	P39	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
GND	-	P40	GND*	GND*	-
I/O	6	P41	K4	T1	377
I/O, V _{REF}	6	P42	M1	R4	380
I/O	6	-	-	T2	383
I/O	6	P43	L4	U1	386
I/O	6	-	M2	R5	389
I/O	6	-	-	V1	392
I/O	6	-	-	T5	395
I/O	6	P44	L3	U2	398
I/O, V _{REF}	6	P45	N1	Т3	401
V _{CCO}	6	-	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
GND	-	-	GND*	GND*	-

XC2S150 Device Pinouts (Continued)

XC2S150 Pad Name					Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	4	P90	R11	AA15	595
V _{CCINT}	-	P91	V _{CCINT} *	V _{CCINT} *	-
V _{CCO}	4	P92	V _{CCO} Bank 4*	V _{CCO} Bank 4*	-
GND	-	P93	GND*	GND*	-
I/O	4	P94	M11	Y15	598
I/O, V _{REF}	4	P95	T11	AB16	601
I/O	4	-	-	AB17	604
I/O	4	P96	N11	V15	607
I/O	4	-	R12	Y16	610
I/O	4	-	-	AA17	613
I/O	4	-	-	W16	616
I/O	4	P97	P11	AB18	619
I/O, V _{REF}	4	P98	T12	AB19	622
V _{CCO}	4	-	V _{CCO} Bank 4*	V _{CCO} Bank 4*	-
GND	-	-	GND*	GND*	-
I/O	4	P99	T13	Y17	625
I/O	4	-	N12	V16	628
I/O	4	-	-	AA18	631
I/O	4	-	-	W17	634
I/O	4	P100	R13	AB20	637
GND	-	-	GND*	GND*	-
I/O	4	-	P12	AA19	640
I/O	4	-	-	V17	643
I/O	4	-	-	Y18	646
I/O	4	P101	P13	AA20	649
I/O	4	P102	T14	W18	652
GND	-	P103	GND*	GND*	-
DONE	3	P104	R14	Y19	655
V _{CCO}	4	P105	V _{CCO} Bank 4*	V _{CCO} Bank 4*	-
V _{CCO}	3	P105	V _{CCO} Bank 3*	V _{CCO} Bank 3*	-
PROGRAM	-	P106	P15	W20	658
I/O (INIT)	3	P107	N15	V19	659
I/O (D7)	3	P108	N14	Y21	662
I/O	3	-	-	V20	665
I/O	3	-	-	AA22	668
I/O	3	-	T15	W21	671
GND	-	-	GND*	GND*	-
I/O	3	P109	M13	U20	674

XC2S150 Device Pinouts (Continued)

XC2S150 Pad Name					Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	3	-	-	U19	677
I/O	3	-	-	V21	680
I/O	3	-	R16	T18	683
I/O	3	P110	M14	W22	686
GND	-	-	GND*	GND*	-
V _{CCO}	3	-	V _{CCO} Bank 3*	V _{CCO} Bank 3*	-
I/O, V _{REF}	3	P111	L14	U21	689
I/O	3	P112	M15	T20	692
I/O	3	-	-	T19	695
I/O	3	-	-	V22	698
I/O	3	-	L12	T21	701
I/O	3	P113	P16	R18	704
I/O	3	-	-	U22	707
I/O, V _{REF}	3	P114	L13	R19	710
I/O (D6)	3	P115	N16	T22	713
GND	-	P116	GND*	GND*	-
V _{CCO}	3	P117	V _{CCO} Bank 3*	V _{CCO} Bank 3*	-
V _{CCINT}	-	P118	V _{CCINT} *	V _{CCINT} *	-
I/O (D5)	3	P119	M16	R21	716
I/O	3	P120	K14	P18	719
I/O	3	-	-	P19	725
I/O	3	-	L16	P20	728
I/O	3	P121	K13	P21	731
I/O	3	-	-	N19	734
I/O	3	P122	L15	N18	740
I/O	3	P123	K12	N20	743
GND	-	P124	GND*	GND*	-
V _{CCO}	3	-	V _{CCO} Bank 3*	V _{CCO} Bank 3*	-
I/O, V _{REF}	3	P125	K16	N21	746
I/O (D4)	3	P126	J16	N22	749
I/O	3	-	J14	M19	752
I/O	3	P127	K15	M20	755
I/O	3	-	-	M18	758
V _{CCINT}	-	P128	V _{CCINT} *	V _{CCINT} *	-
I/O, TRDY ⁽¹⁾	3	P129	J15	M22	764
V _{cco}	3	P130	V _{CCO} Bank 3*	V _{CCO} Bank 3*	-
V _{cco}	2	P130	V _{CCO} Bank 2*	V _{CCO} Bank 2*	-
GND	-	P131	GND*	GND*	-

XC2S200 Device Pinouts

XC2S200 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
GND	-	P1	GND*	GND*	-
TMS	-	P2	D3	D3	-
I/O	7	P3	C2	B1	257
I/O	7	-	-	E4	263
I/O	7	-	-	C1	266
I/O	7	-	A2	F5	269
GND	-	-	GND*	GND*	-
I/O, V _{REF}	7	P4	B1	D2	272
I/O	7	-	-	E3	275
I/O	7	-	-	F4	281
GND	-	-	GND*	GND*	-
I/O	7	-	E3	G5	284
I/O	7	P5	D2	F3	287
GND	-	-	GND*	GND*	-
V _{CCO}	7	-	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
I/O, V _{REF}	7	P6	C1	E2	290
I/O	7	P7	F3	E1	293
I/O	7	-	-	G4	296
I/O	7	-	-	G3	299
I/O	7	-	E2	H5	302
GND	-	-	GND*	GND*	-
I/O	7	P8	E4	F2	305
I/O	7	-	-	F1	308
I/O, V _{REF}	7	P9	D1	H4	314
I/O	7	P10	E1	G1	317
GND	-	P11	GND*	GND*	-
V _{CCO}	7	P12	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
V _{CCINT}	-	P13	V _{CCINT} *	V _{CCINT} *	-
I/O	7	P14	F2	H3	320
I/O	7	P15	G3	H2	323
I/O	7	-	-	J4	326
I/O	7	-	-	H1	329
I/O	7	-	F1	J5	332
GND	-	-	GND*	GND*	-
I/O	7	P16	F4	J2	335
I/O	7	-	-	J3	338
I/O	7	-	-	J1	341
I/O	7	P17	F5	K5	344
I/O	7	P18	G2	K1	347
GND	-	P19	GND*	GND*	-

XC2S200 Device Pinouts (Continued)

XC2S200 Pad Name					Bndry
Function	Bank	PQ208	FG256	FG456	Scan
V _{CCO}	7	-	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
I/O, V _{REF}	7	P20	H3	K3	350
I/O	7	P21	G4	K4	353
I/O	7	-	-	K2	359
I/O	7	-	H2	L6	362
I/O	7	P22	G5	L1	365
I/O	7	-	-	L5	368
I/O	7	P23	H4	L4	374
I/O, IRDY ⁽¹⁾	7	P24	G1	L3	377
GND	-	P25	GND*	GND*	-
V _{CCO}	7	P26	V _{CCO} Bank 7*	V _{CCO} Bank 7*	-
V _{CCO}	6	P26	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
I/O, TRDY ⁽¹⁾	6	P27	J2	M1	380
V _{CCINT}	-	P28	V _{CCINT} *	V _{CCINT} *	-
I/O	6	-	-	M6	389
I/O	6	P29	H1	M3	392
I/O	6	-	J4	M4	395
I/O	6	-	-	N1	398
I/O	6	P30	J1	M5	404
I/O, V _{REF}	6	P31	J3	N2	407
V _{CCO}	6	-	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
GND	-	P32	GND*	GND*	-
I/O	6	P33	K5	N3	410
I/O	6	P34	K2	N4	413
I/O	6	-	-	P1	416
I/O	6	-	-	N5	419
I/O	6	P35	K1	P2	422
GND	-	-	GND*	GND*	-
I/O	6	-	K3	P4	425
I/O	6	-	-	R1	428
I/O	6	-	-	P5	431
I/O	6	P36	L1	P3	434
I/O	6	P37	L2	R2	437
V _{CCINT}	-	P38	V _{CCINT} *	V_{CCINT}^{*}	-
V _{CCO}	6	P39	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
GND	-	P40	GND*	GND*	-
I/O	6	P41	K4	T1	440
I/O, V _{REF}	6	P42	M1	R4	443

XC2S200 Device Pinouts (Continued)

XC2S200 Pad Name					Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	6	-	-	T2	449
I/O	6	P43	L4	U1	452
GND	-	-	GND*	GND*	-
I/O	6	-	M2	R5	455
I/O	6	-	-	V1	458
I/O	6	-	-	T5	461
I/O	6	P44	L3	U2	464
I/O, V _{REF}	6	P45	N1	Т3	467
V _{CCO}	6	-	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
GND	-	-	GND*	GND*	-
I/O	6	P46	P1	T4	470
I/O	6	-	L5	W1	473
GND	-	-	GND*	GND*	-
I/O	6	-	-	V2	476
I/O	6	-	-	U4	482
I/O, V _{REF}	6	P47	N2	Y1	485
GND	-	-	GND*	GND*	-
I/O	6	-	M4	W2	488
I/O	6	-	-	V3	491
I/O	6	-	-	V4	494
I/O	6	P48	R1	Y2	500
I/O	6	P49	M3	W3	503
M1	-	P50	P2	U5	506
GND	-	P51	GND*	GND*	-
MO	-	P52	N3	AB2	507
V _{CCO}	6	P53	V _{CCO} Bank 6*	V _{CCO} Bank 6*	-
V _{CCO}	5	P53	V _{CCO} Bank 5*	V _{CCO} Bank 5*	-
M2	-	P54	R3	Y4	508
I/O	5	-	-	W5	518
I/O	5	-	-	AB3	521
I/O	5	-	N5	V7	524
GND	-	-	GND*	GND*	-
I/O, V _{REF}	5	P57	T2	Y6	527
I/O	5	-	-	AA4	530
I/O	5	-	-	AB4	536
I/O	5	-	P5	W6	539
I/O	5	P58	Т3	Y7	542
GND	-	-	GND*	GND*	-

XC2S200 Device Pinouts (Continued)

XC2S200 Pad Name					Bndry
Function	Bank	PQ208	FG256	FG456	Scan
V _{CCO}	5	-	V _{CCO} Bank 5*	V _{CCO} Bank 5*	-
I/O, V _{REF}	5	P59	T4	AA5	545
I/O	5	P60	M6	AB5	548
I/O	5	-	-	V8	551
I/O	5	-	-	AA6	554
I/O	5	-	T5	AB6	557
GND	-	-	GND*	GND*	-
I/O	5	P61	N6	AA7	560
I/O	5	-	-	W7	563
I/O, V _{REF}	5	P62	R5	W8	569
I/O	5	P63	P6	Y8	572
GND	-	P64	GND*	GND*	-
V _{CCO}	5	P65	V _{CCO} Bank 5*	V _{CCO} Bank 5*	-
V _{CCINT}	-	P66	V _{CCINT} *	V _{CCINT} *	-
I/O	5	P67	R6	AA8	575
I/O	5	P68	M7	V9	578
I/O	5	-	-	AB8	581
I/O	5	-	-	W9	584
I/O	5	-	-	AB9	587
GND	-	-	GND*	GND*	-
I/O	5	P69	N7	Y9	590
I/O	5	-	-	V10	593
I/O	5	-	-	AA9	596
I/O	5	P70	Т6	W10	599
I/O	5	P71	P7	AB10	602
GND	-	P72	GND*	GND*	-
V _{CCO}	5	-	V _{CCO} Bank 5*	V _{CCO} Bank 5*	-
I/O, V _{REF}	5	P73	P8	Y10	605
I/O	5	P74	R7	V11	608
I/O	5	-	-	AA10	614
I/O	5	-	T7	W11	617
I/O	5	P75	T8	AB11	620
I/O	5	-	-	U11	623
V _{CCINT}	-	P76	V _{CCINT} *	V _{CCINT} *	-
I, GCK1	5	P77	R8	Y11	635
V _{CCO}	5	P78	V _{CCO} Bank 5*	V _{CCO} Bank 5*	-
V _{CCO}	4	P78	V _{CCO} Bank 4*	V _{CCO} Bank 4*	-
GND	-	P79	GND*	GND*	-